

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/828,148	WASENIUS, REIDAR	
Examiner		Raymond S. Dean	Art Unit	Page 1 of 1
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	B	US-6,901,434	05-2005	Lunsford et al.	709/216
	C	US-			
	D	US-			
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	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Haartsen, J.C.; Mattisson, S.; Proceedings of the IEEE, Volume: 88, Issue: 10, Oct. 200 Pages 1651 - 1661
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.